



MOTOROLA

MPQ6001,N MPQ6002,N MPQ6501,N MPQ6502,N

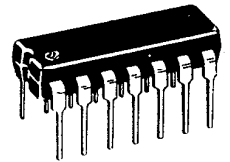
QUAD DUAL-IN-LINE SILICON ANNULAR[♦] COMPLEMENTARY PAIR TRANSISTORS

... designed for high-speed switching circuits, DC to VHF amplifier applications and complementary circuitry.

- Maximum Power Dissipation @ $T_A = 25^\circ\text{C}$
 $P_D = 1.25$ Watts – MPQ6001,MPQ6002,MPQ6501,MPQ6502
 $= 0.9$ Watts – MPQ6001N,MPQ6002N,MPQ6501N,MPQ6502N
- DC Current Gain Specified – 1.0 to 300 mAdc
- High Current-Gain-Bandwidth Product –
 $f_T = 400$ MHz (Typ) @ $I_C = 50$ mAdc
- NPN Transistor Similar to 2N2218 or 2N2219
- PNP Transistor Similar to 2N2904 or 2N2905
- Compact Size Compatible with IC Automatic Insertion Equipment

QUAD DUAL-IN-LINE SILICON COMPLEMENTARY PAIR TRANSISTORS

CASE 646
PLASTIC PACKAGE



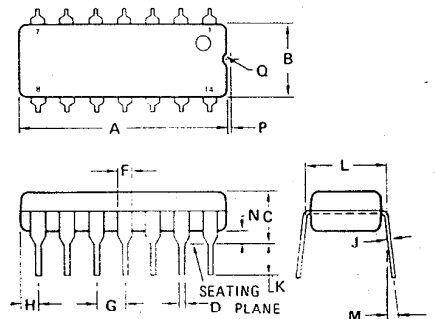
MAXIMUM RATINGS

Rating	Symbol	Value	Unit	
Collector-Emitter Voltage	V_{CEO}	30	Vdc	
Collector-Base Voltage	V_{CB}	60	Vdc	
Emitter-Base Voltage	V_{EB}	5.0	Vdc	
Collector Current – Continuous	I_C	500	mAdc	
		Each Transistor	Four Transistors Equal Power	
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (1) MPQ6001, MPQ6002, MPQ6501, MPQ6502 MPQ6001N, MPQ6002N, MPQ6501N, MPQ6502N Derate above 25°C	P_D	0.65 0.5	1.25 0.9	Watts mW/ $^\circ\text{C}$
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ MPQ6001, MPQ6002, MPQ6501, MPQ6502 MPQ6001N, MPQ6002N, MPQ6501N, MPQ6502N Derate above 25°C	P_D	5.18 4.0	10 7.2	Watts mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$	

(1) Second Breakdown occurs at power levels greater than 3 times the power dissipation rating.

THERMAL CHARACTERISTICS

Characteristic	Junction to Case	Junction to Ambient	Unit
Thermal Resistance			$^\circ\text{C}/\text{W}$
Each Die			
MPQ6001, MPQ6002, MPQ6501, MPQ6502	125	193	
MPQ6001N, MPQ6002N, MPQ6501N, MPQ6502N	151	250	
Effective, 4 Die			
MPQ6001, MPQ6002, MPQ6501, MPQ6502	41.6	100	
MPQ6001N, MPQ6002N, MPQ6501N, MPQ6502N	52	134	
Coupling Factors			%
Q1-Q4 or Q2-Q3	MPQ6001, MPQ6002 MPQ6501, MPQ6502	30	60
	MPQ6001N, MPQ6002N MPQ6501N, MPQ6502N	34	70
Q1-Q2 or Q3-Q4	MPQ6001, MPQ6002 MPQ6501, MPQ6502	2.0	24
	MPQ6001N, MPQ6002N MPQ6501N, MPQ6502N	2.0	26



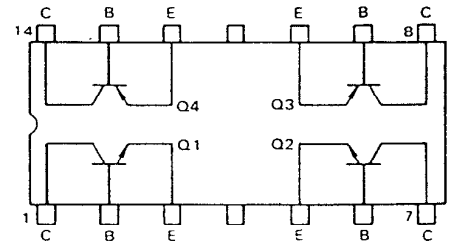
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	18.16	18.80	0.715	0.740
B	6.10	6.60	0.240	0.260
C	4.06	4.57	0.160	0.180
D	0.38	0.51	0.015	0.020
F	1.02	1.52	0.040	0.060
G	2.54 BSC		0.100 BSC	
H	1.32	1.83	0.052	0.072
J	0.20	0.30	0.008	0.012
K	2.92	3.43	0.115	0.135
L	7.37	7.87	0.290	0.310
M	- 10 $^\circ$		- 10 $^\circ$	
N	0.51	1.02	0.020	0.040
P	0.13	0.38	0.005	0.015
Q	0.51	0.76	0.020	0.030

NOTES:

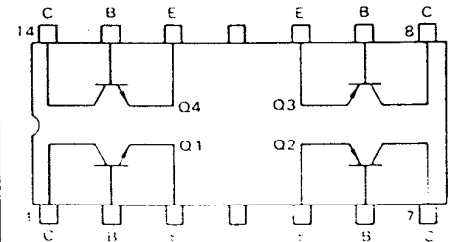
- LEADS WITHIN 0.13 mm (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION.
- DIMENSION "L" TO CENTER OF LEADS WHEN FORMED PARALLEL

CONNECTION DIAGRAM

MPQ6001,N, MPQ6002,N,



MPQ6501,N, MPQ6502,N



THERMAL COUPLING AND EFFECTIVE THERMAL RESISTANCE

In multiple chip devices, coupling of heat between die occurs. The junction temperature can be calculated as follows:

$$(1) \Delta T_{J1} = R_{\theta 1} P_{D1} + R_{\theta 2} K_{\theta 2} P_{D2} + R_{\theta 3} K_{\theta 3} P_{D3} + R_{\theta 4} K_{\theta 4} P_{D4}$$

Where ΔT_{J1} is the change in junction temperature of die 1
 $R_{\theta 1}$ thru 4 is the thermal resistance of die 1 through 4
 P_{D1} thru 4 is the power dissipated in die 1 through 4
 $K_{\theta 2}$ thru 4 is the thermal coupling between die 1 and die 2 through 4.

An effective package thermal resistance can be defined as follows:

$$(2) R_{\theta(EFF)} = \Delta T_{J1} / P_{DT}$$

where: P_{DT} is the total package power dissipation.

Assuming equal thermal resistance for each die, equation (1) simplifies to

$$(3) \Delta T_{J1} = R_{\theta 1} (P_{D1} + K_{\theta 2} P_{D2} + K_{\theta 3} P_{D3} + K_{\theta 4} P_{D4})$$

For the conditions where $P_{D1} = P_{D2} = P_{D3} = P_{D4}$, $P_{DT} = 4 P_{D1}$, equation (3) can be further simplified and by substituting into equation (2) results in

$$(4) R_{\theta(EFF)} = R_{\theta 1} (1 + K_{\theta 2} + K_{\theta 3} + K_{\theta 4}) / 4$$

Values for the coupling factors when either the case or the ambient is used as a reference are given in the table on page 1. If significant power is to be dissipated in two die, die at the opposite ends of the package should be used so that lowest possible junction temperatures will result.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage(1) ($I_C = 10 \text{ mAdc}$, $I_B = 0$)	BV_{CEO}	30	—	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 10 \mu\text{Adc}$, $I_E = 0$)	BV_{CBO}	60	—	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10 \mu\text{Adc}$, $I_C = 0$)	BV_{EBO}	5.0	—	—	Vdc
Collector Cutoff Current ($V_{CB} = 50 \text{ Vdc}$, $I_E = 0$)	I_{CBO}	—	—	30	nAdc
Emitter Cutoff Current ($V_{EB} = 3.0 \text{ Vdc}$, $I_C = 0$)	I_{EBO}	—	—	30	nAdc
ON CHARACTERISTICS					
DC Current Gain(1) ($I_C = 1.0 \text{ mAdc}$, $V_{CE} = 10 \text{ Vdc}$)	h_{FE}	25 50	—	—	—
($I_C = 10 \text{ mAdc}$, $V_{CE} = 10 \text{ Vdc}$)		35 75	—	—	—
($I_C = 150 \text{ mAdc}$, $V_{CE} = 10 \text{ Vdc}$)		40 100	—	—	—
($I_C = 300 \text{ mAdc}$, $V_{CE} = 10 \text{ Vdc}$)		20 30	—	—	—
Collector-Emitter Saturation Voltage (1) ($I_C = 150 \text{ mAdc}$, $I_B = 15 \text{ mAdc}$) ($I_C = 300 \text{ mAdc}$, $I_B = 30 \text{ mAdc}$)	$V_{CE(sat)}$	—	—	0.4 1.4	Vdc
Base-Emitter Saturation Voltage (1) ($I_C = 150 \text{ mAdc}$, $I_B = 15 \text{ mAdc}$) ($I_C = 300 \text{ mAdc}$, $I_B = 30 \text{ mAdc}$)	$V_{BE(sat)}$	—	—	1.3 2.0	Vdc
DYNAMIC CHARACTERISTICS					
Current-Gain-Bandwidth Product (1) ($I_C = 50 \text{ mAdc}$, $V_{CE} = 20 \text{ Vdc}$, $f = 100 \text{ MHz}$)	f_T	200	350	—	MHz
Output Capacitance ($V_{CB} = 10 \text{ Vdc}$, $I_E = 0$, $f = 100 \text{ kHz}$)	C_{ob}	—	6.0 4.5	8.0 8.0	pF
Input Capacitance ($V_{EB} = 2.0 \text{ Vdc}$, $I_C = 0$, $f = 100 \text{ kHz}$)	C_{ib}	—	20 17	30 30	pF
SWITCHING CHARACTERISTICS					
Turn-On Time ($V_{CC} = 30 \text{ Vdc}$, $V_{BE(on)} = 0.5 \text{ Vdc}$, $I_C = 150 \text{ mAdc}$, $I_B = 15 \text{ mAdc}$, Figure 1)	t_{on}	—	30	—	ns
Turn-Off Time ($V_{CC} = 30 \text{ Vdc}$, $I_C = 150 \text{ mAdc}$, $I_B = I_{B2} = 15 \text{ mAdc}$, Figure 2)	t_{off}	—	225	—	ns

(1) Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle = 2%.

NPN SATURATED SWITCHING TIME TEST CIRCUITS

For NPN Switching Tests, reverse the diodes, voltage polarities, and input pulses.

FIGURE 1 - NPN TURN-ON TIME

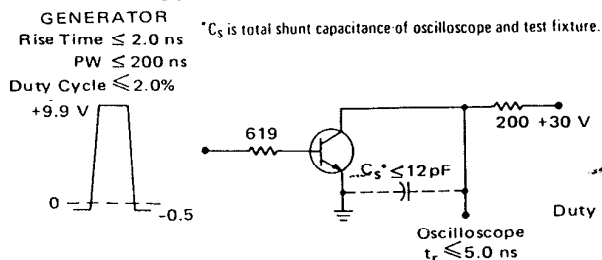
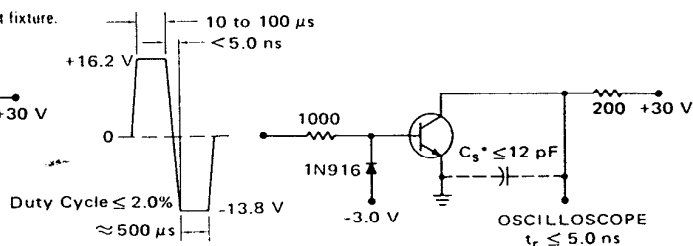


FIGURE 2 - NPN TURN-OFF TIME



MOTOROLA Semiconductor Products Inc.

NPN DATA

FIGURE 3 – NORMALIZED DC CURRENT GAIN

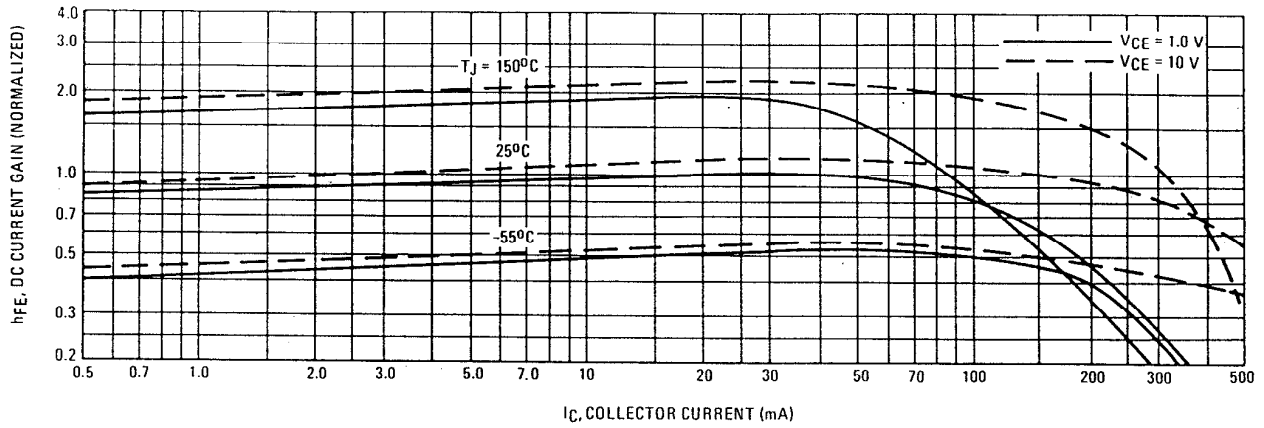


FIGURE 4 – "ON" VOLTAGES

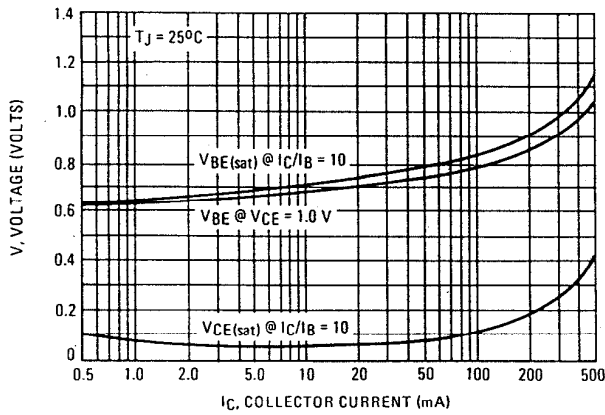
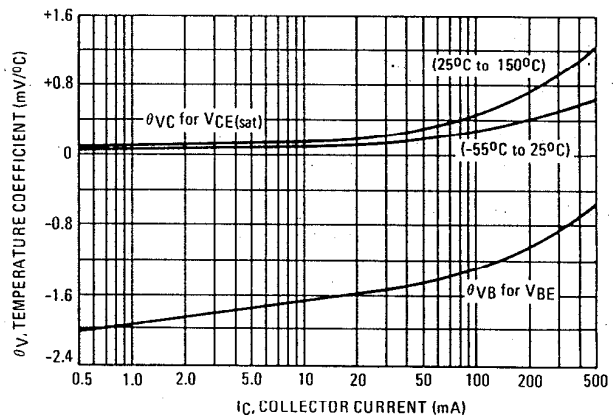


FIGURE 5 – TEMPERATURE COEFFICIENTS



NOISE FIGURE
($V_{CE} = 10\text{ Vdc}$, $T_A = 25^\circ\text{C}$)

FIGURE 6 – FREQUENCY EFFECTS

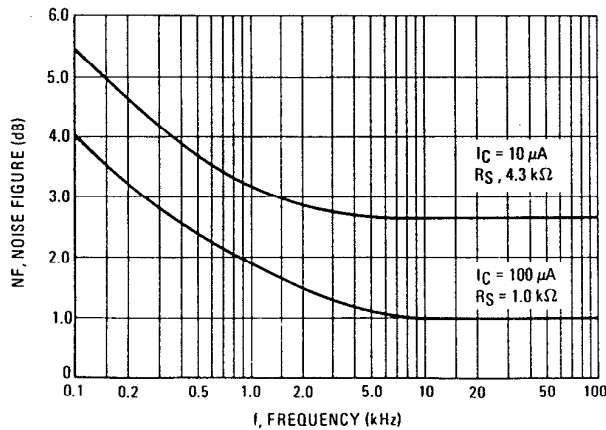
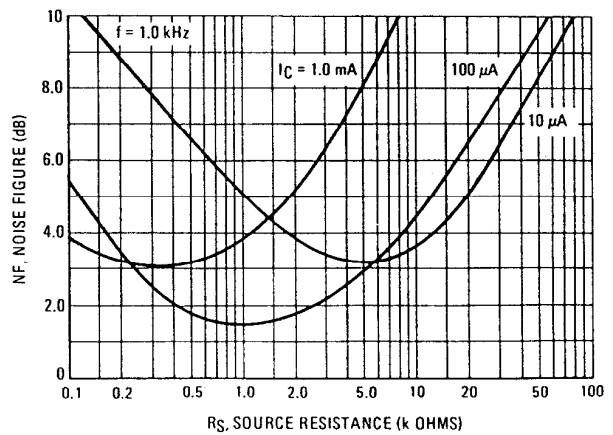
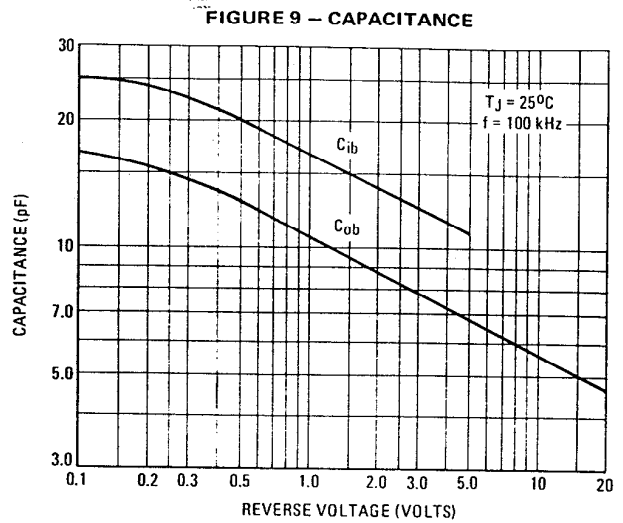
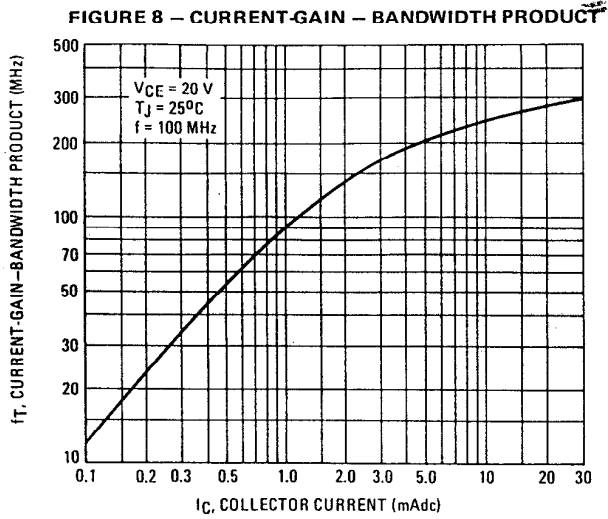


FIGURE 7 – SOURCE RESISTANCE EFFECTS



NPN DATA



SWITCHING TIME CHARACTERISTICS

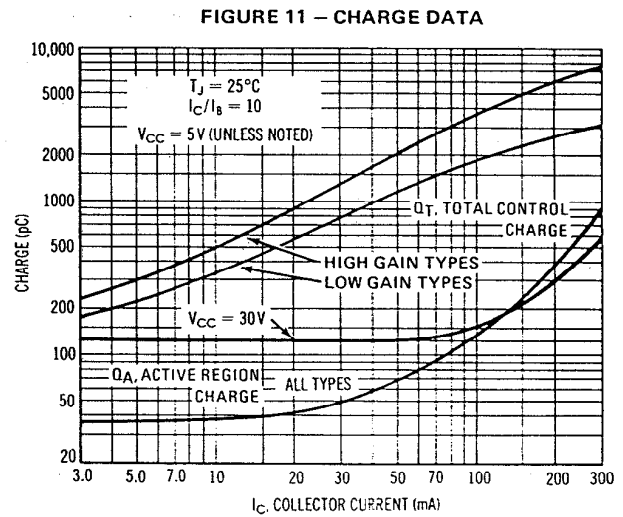
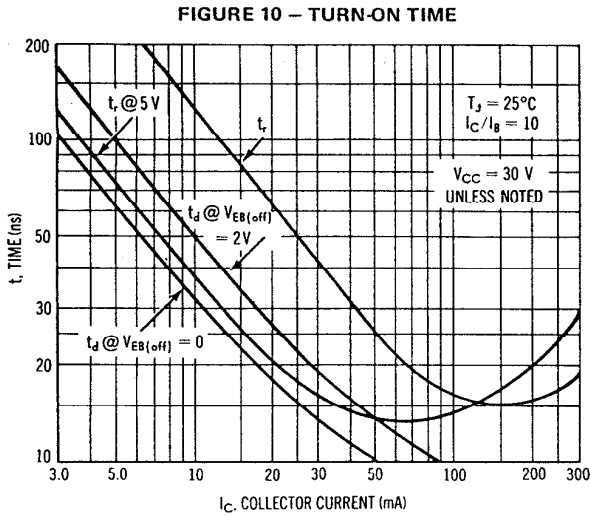
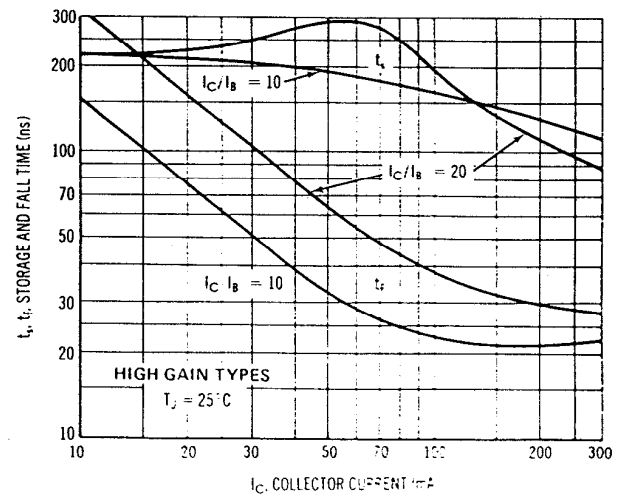
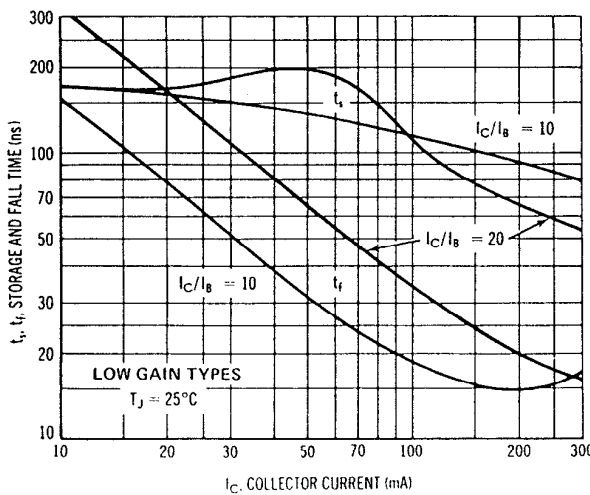


FIGURE 12 – TURN-OFF TIME



PNP DATA

FIGURE 13 – DC CURRENT GAIN

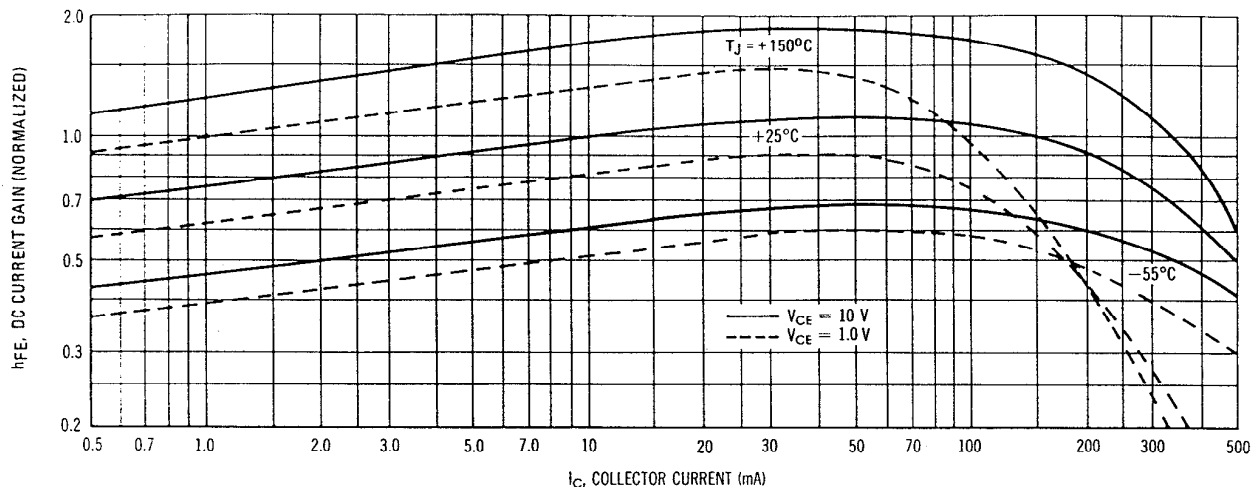


FIGURE 14 – "ON" VOLTAGES

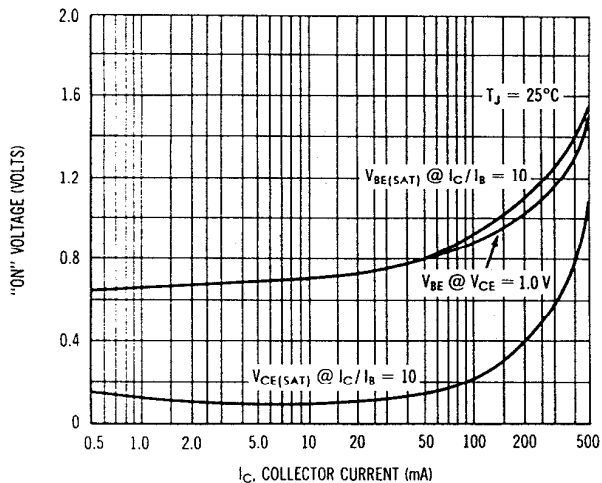
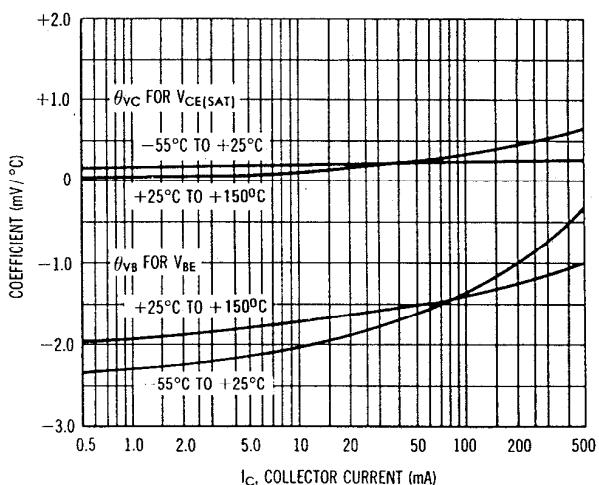


FIGURE 15 – TEMPERATURE COEFFICIENTS



NOISE FIGURE
(V_{CE} = 10 V, T_A = 25°C)

FIGURE 16 – FREQUENCY EFFECTS

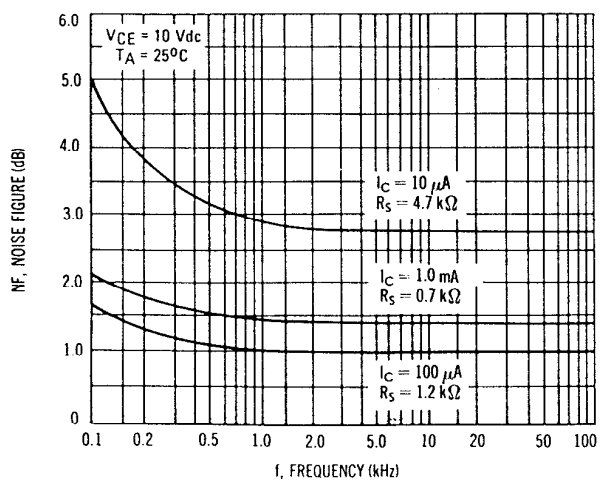
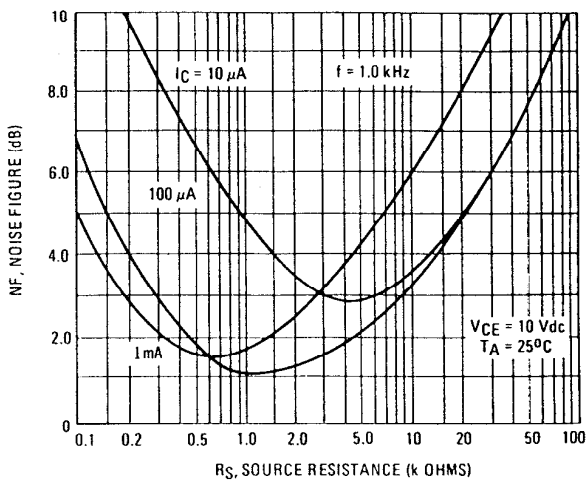


FIGURE 17 – SOURCE RESISTANCE EFFECTS



PNP DATA

FIGURE 18 – CURRENT-GAIN BANDWIDTH PRODUCT

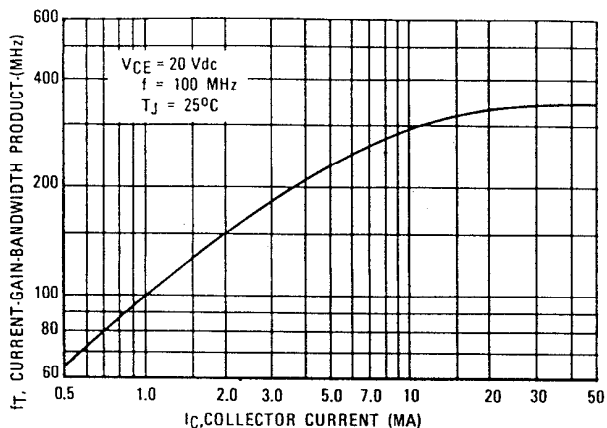


FIGURE 19 – CAPACITANCE

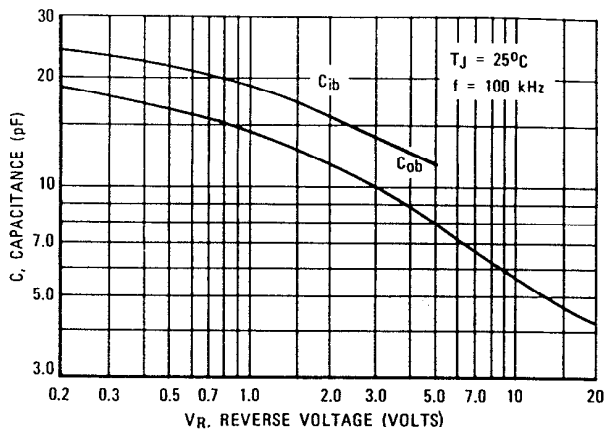


FIGURE 20 – TURN ON TIME

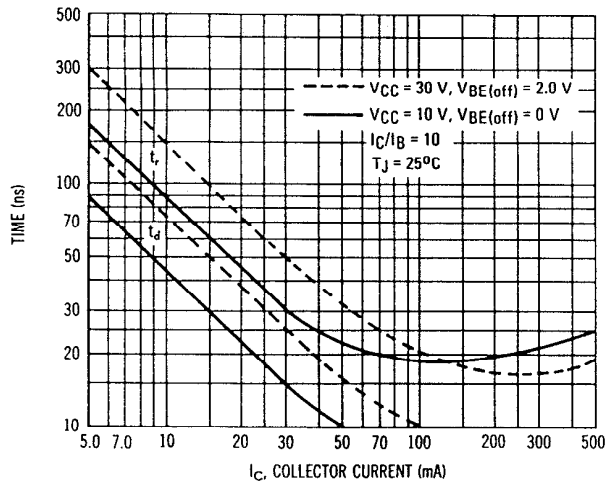


FIGURE 21 – CHARGE DATA

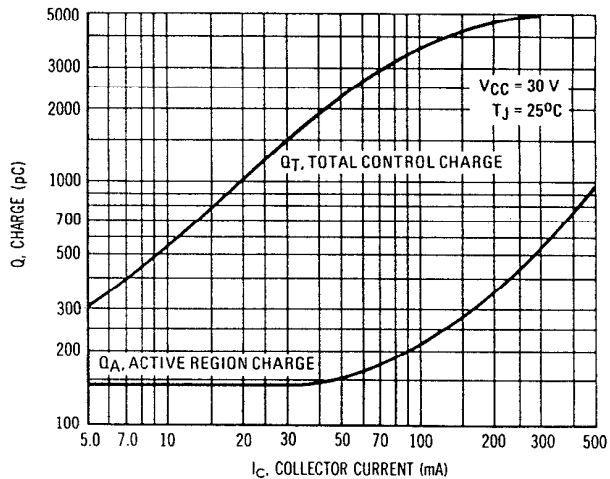


FIGURE 22 – STORAGE TIME

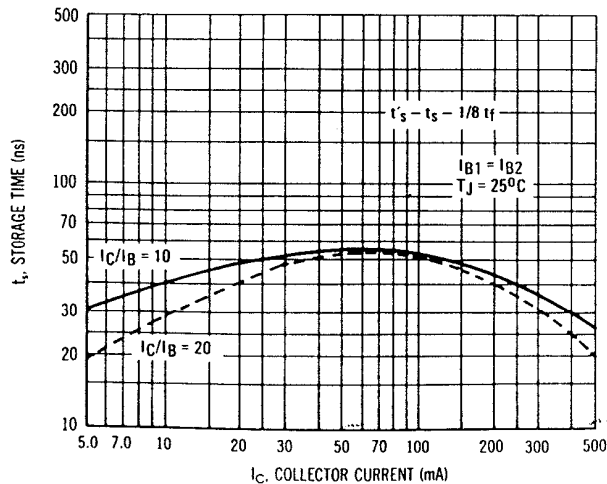
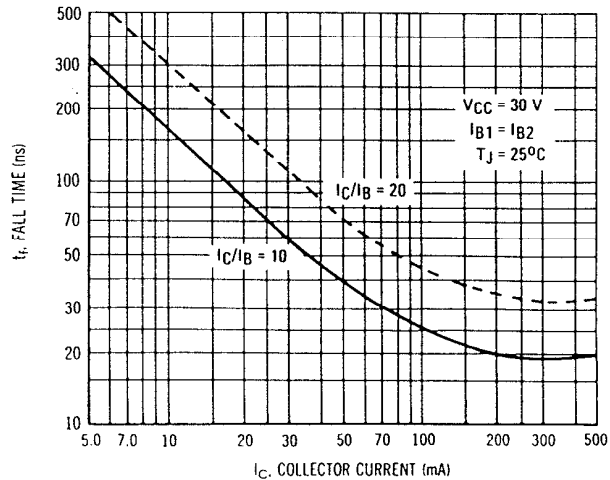


FIGURE 23 – FALL TIME





Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

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Факс: 8 (812) 320-02-42

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